

Notice of References Cited	Application/Control No. 10/669,469	Applicant(s)/Patent Under Reexamination OKUGAWA ET AL.	
	Examiner Matthew D. Matzek	Art Unit 1771	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,136,146	10-2000	Phan et al.	162/109
	B	US-4,225,382	09-1980	Kearney et al.	162/111
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10-1166	01-1998	Japan	SAITO et al.	B 65 B 81/03
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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